

On-machine Measurement for Precision Corrective-polishing of Aspheres and Freeform Surfaces

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Sub-title

An update on an on-going product development

Acknowledgements

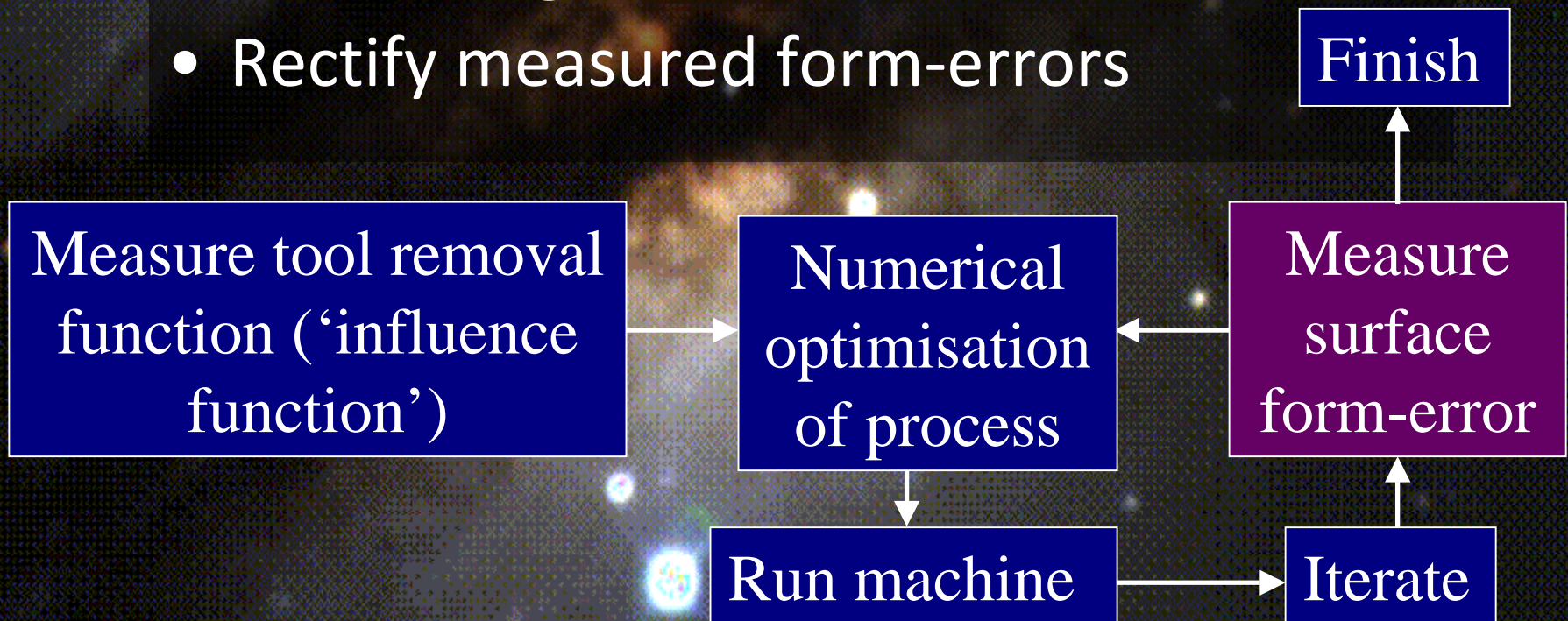
- Funding from PPARC (now STFC) PIPSS scheme
- Collaboration between UCL, Zeeko Ltd and the OpTIC Technium

Areas of interest include ...

- Optical lenses and mirrors
 - Head-up displays
 - Defence and space optics
 - Telescope and instrumentation optics
- Hip and knee joint implants
- Turbine blades
- Moulds and dies
- Mandrels for X-ray mirrors
- But, we'll address larger components for now!

The polishing technology

- Range of CNC polishing machines
 - Zeeko-Classic inflated bonnet tools
 - Fluid-jet polishing
- Polish rough surfaces
- Rectify measured form-errors



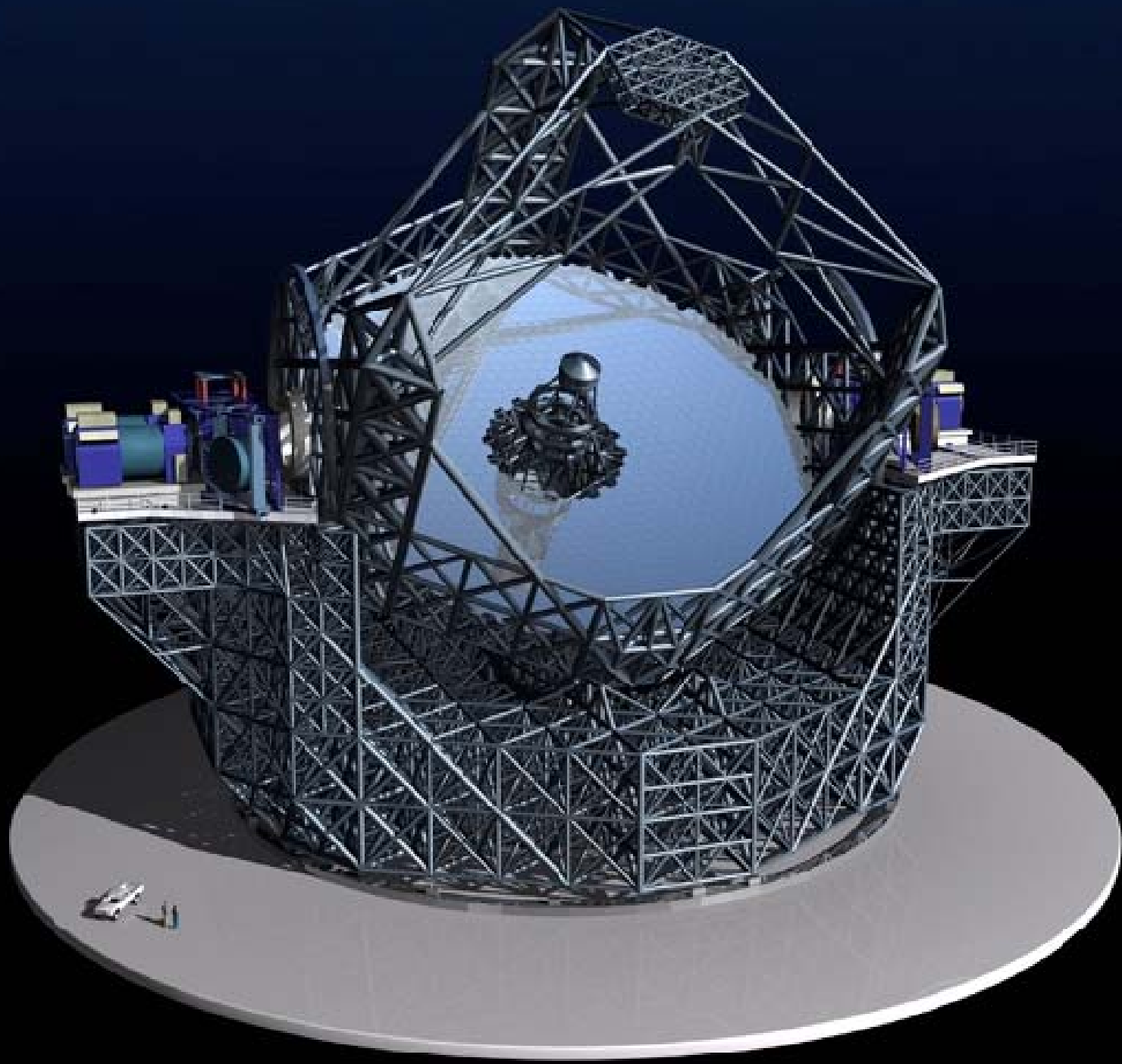
Aspheres & free-form surfaces

- Measurement dynamic range
- Need for null ('corrective') optics
 - The Hubble Space telescope problem!

For large parts

- Risk of damage in handling
- Substantial down-time measuring off-machine,
 - moving the component
 - re-adjusting at test setup and back on machine
 - thermal stabilization





On-machine metrology

- Demountable interferometer module to fit tool-chuck of the larger Zeeko machines
- Overlapping sub-aperture measurements
 - Sub-apertures cover pupil optimally
 - Sub-apertures are stitched in software
 - Residuals in overlap-regions => estimate of uncertainty of stitched results

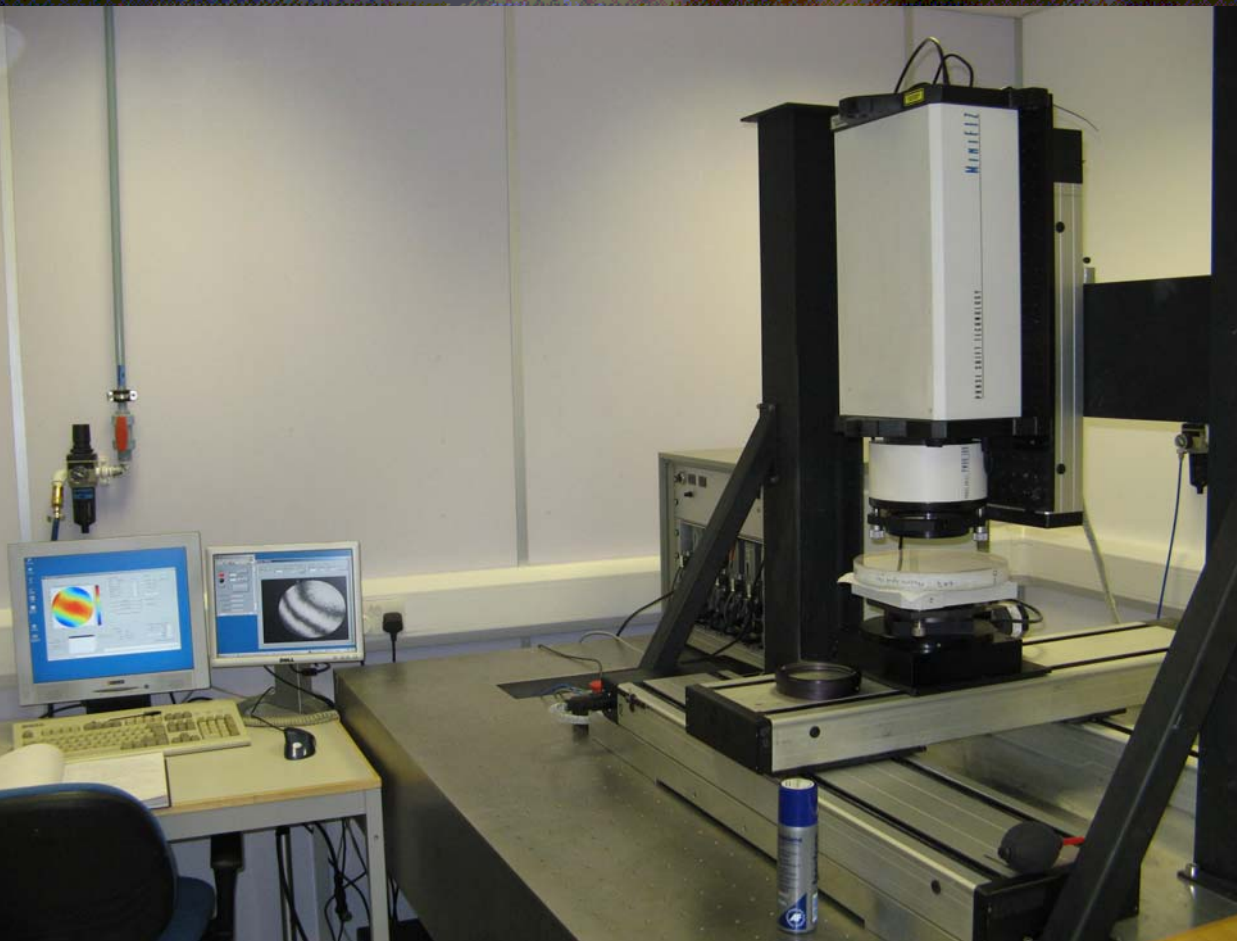
Advantages

- Increased dynamic range for on- and off- axis aspheres
- Close-up test reduces effects of air-turbulence
- Increased spatial resolution (more pixels)
- Handle large parts
- Handle steeply convex parts
- Possible application to convex/concave parts (e.g. saddles)

Key issues

- Size-envelope of module
- Environmental conditions
 - Vibration:- ambient, machine servos
 - Heat-load from machine and process
- Effectiveness of stitching software

Test-rig for software development



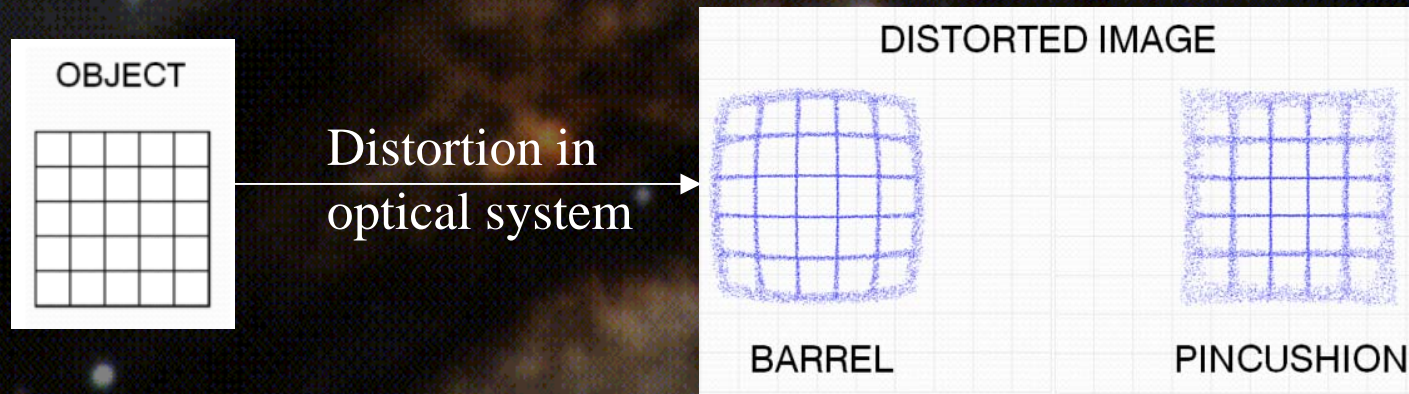
Stepper-motor
rolling-element
slide-ways

Old Zygo PTI
interferometer
with Vidicon

Vibration-isolated
bench

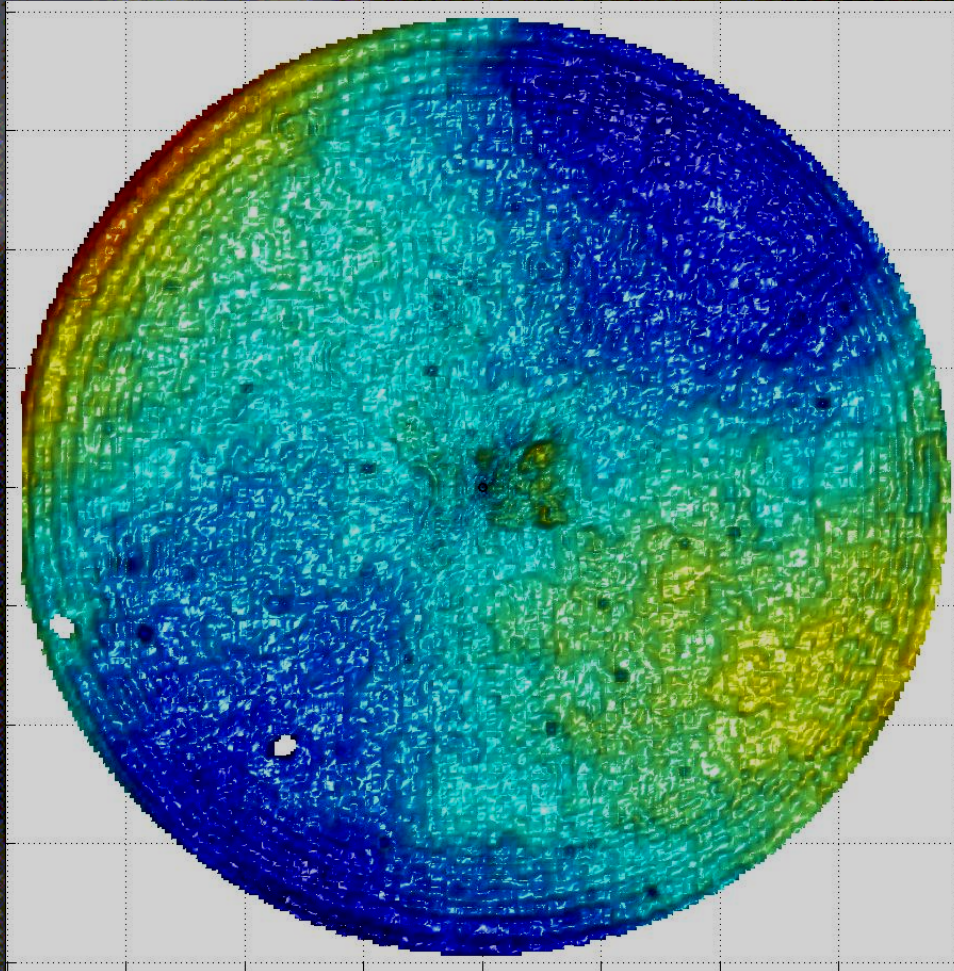
Stitching

- Individual phase-maps require correction for geometric distortion



- In the general case, stitching will not work well without distortion correction, especially on strongly-curved surfaces.

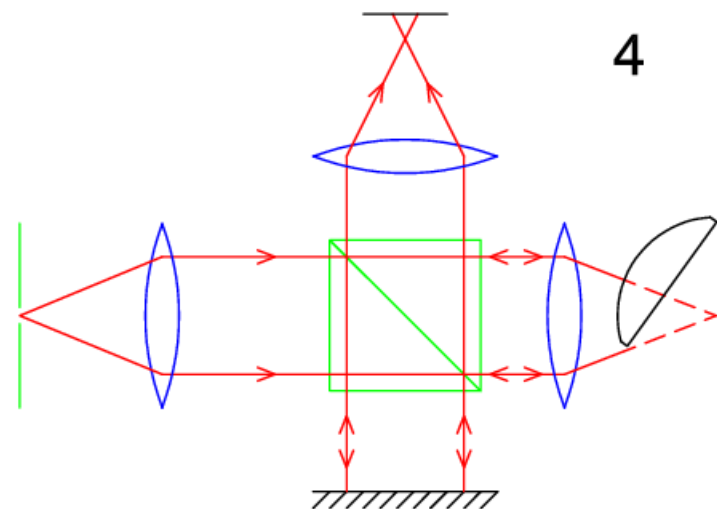
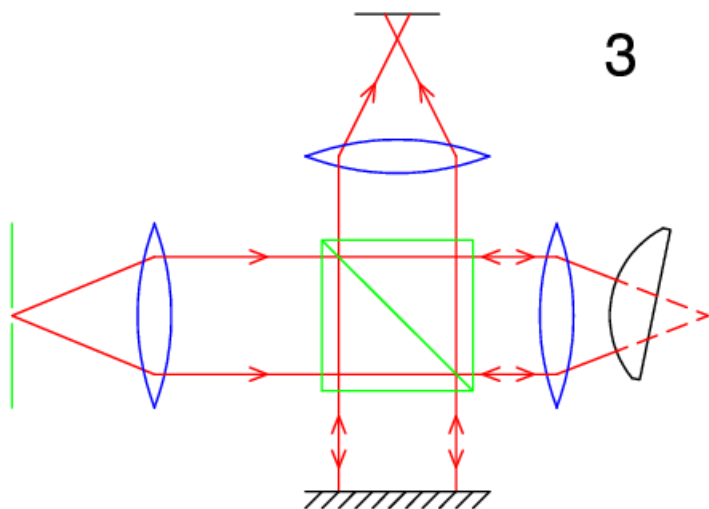
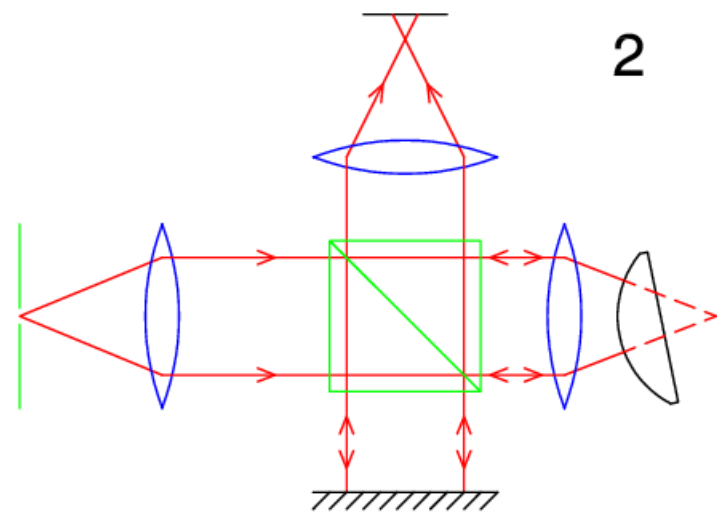
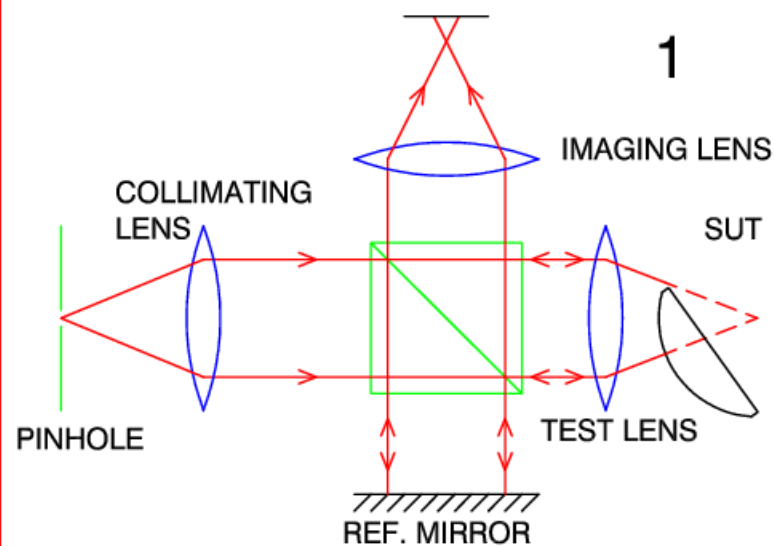
Effect of distortion



Stitching

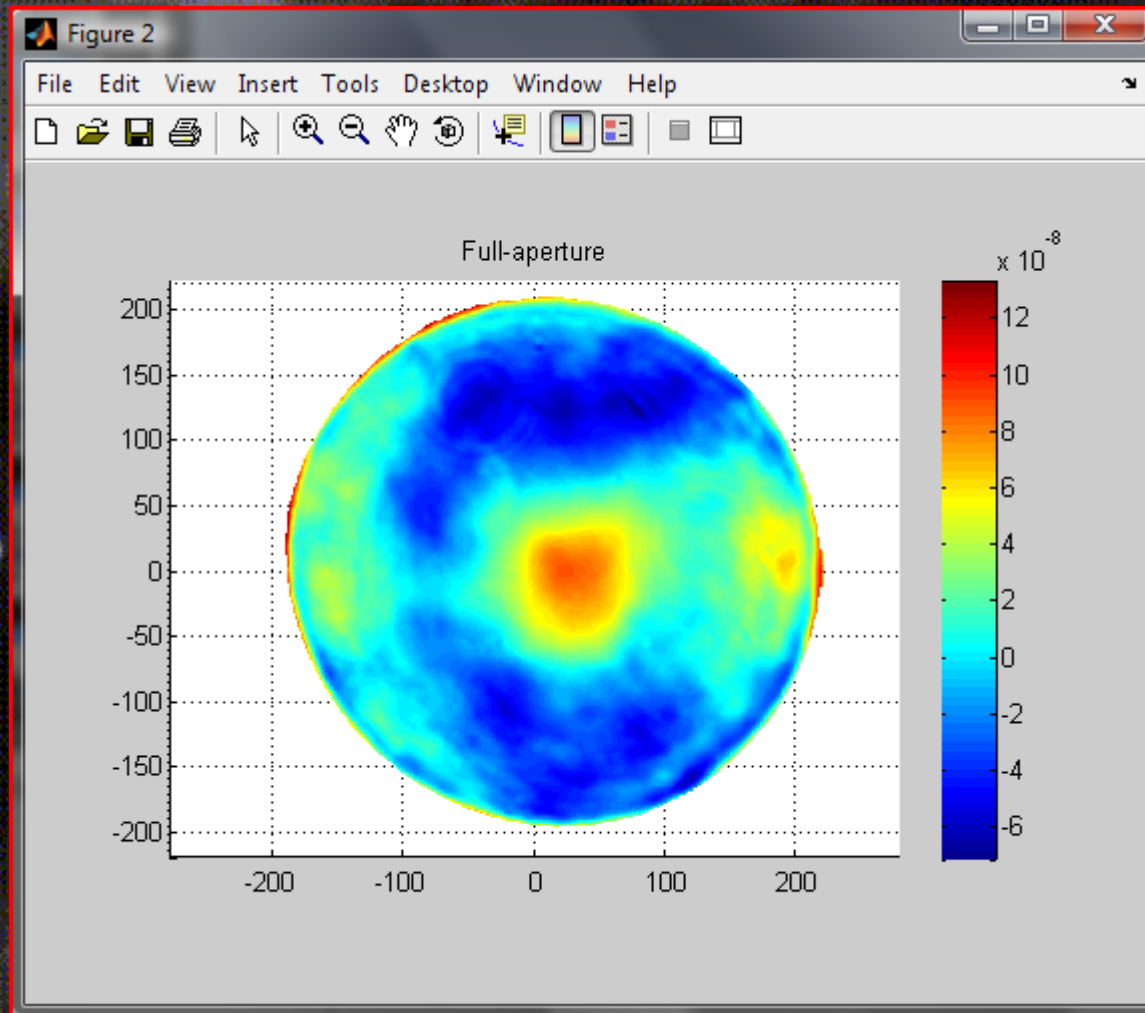
- Stitching then proceeds by optimization of the residuals in the overlap areas.
- The stitching error is estimated from residual noise, merit function and analysing data in the sub-aperture overlap areas.

Example stitching a convex part

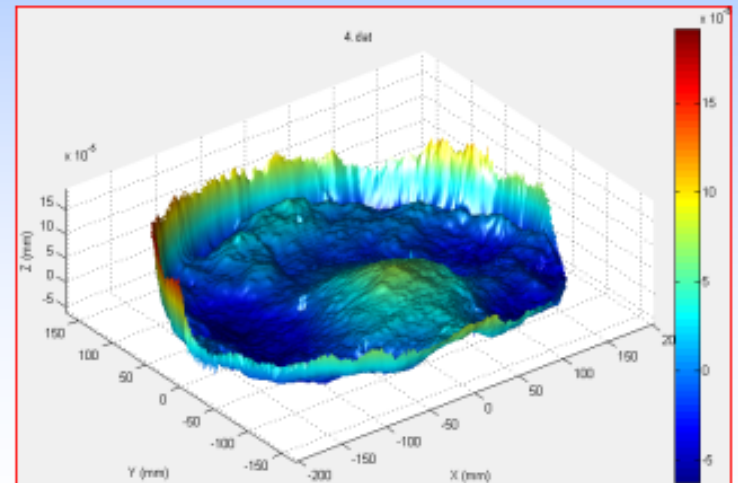
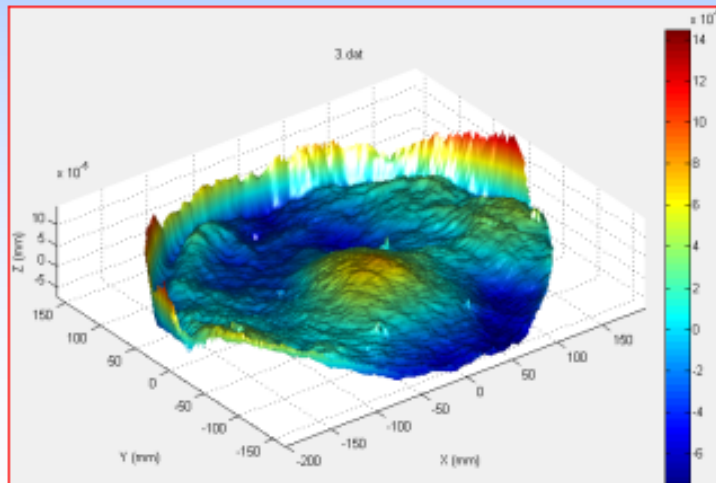
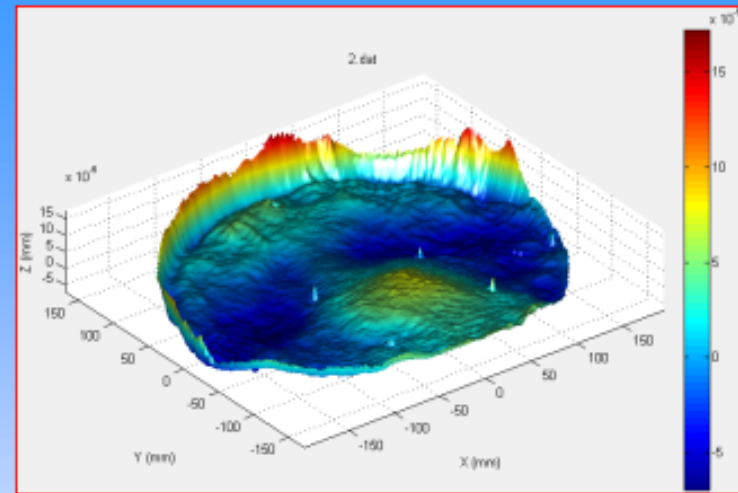
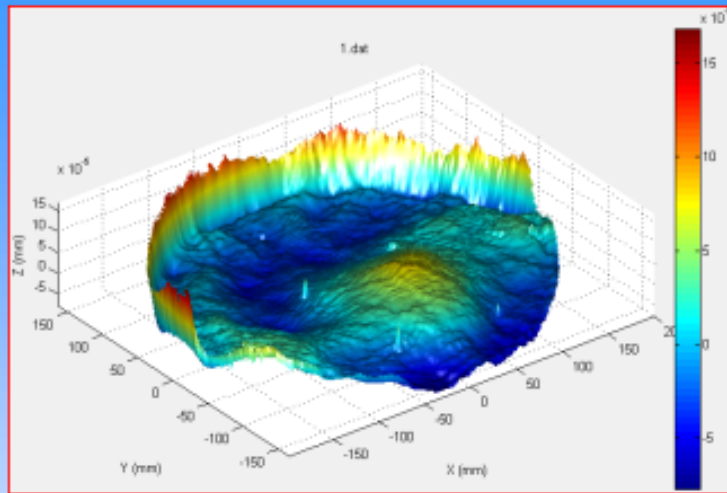


First results

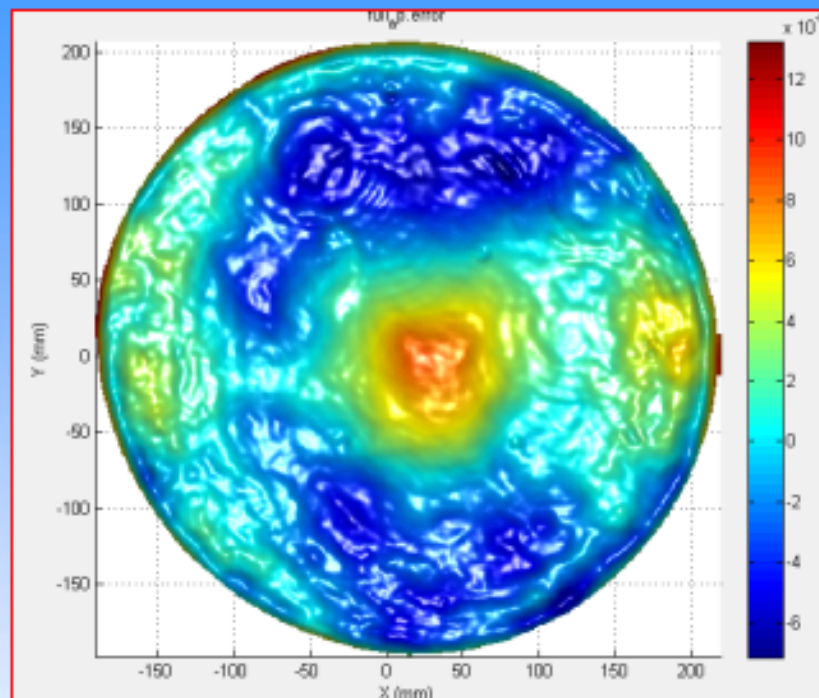
1. Full aperture measurement



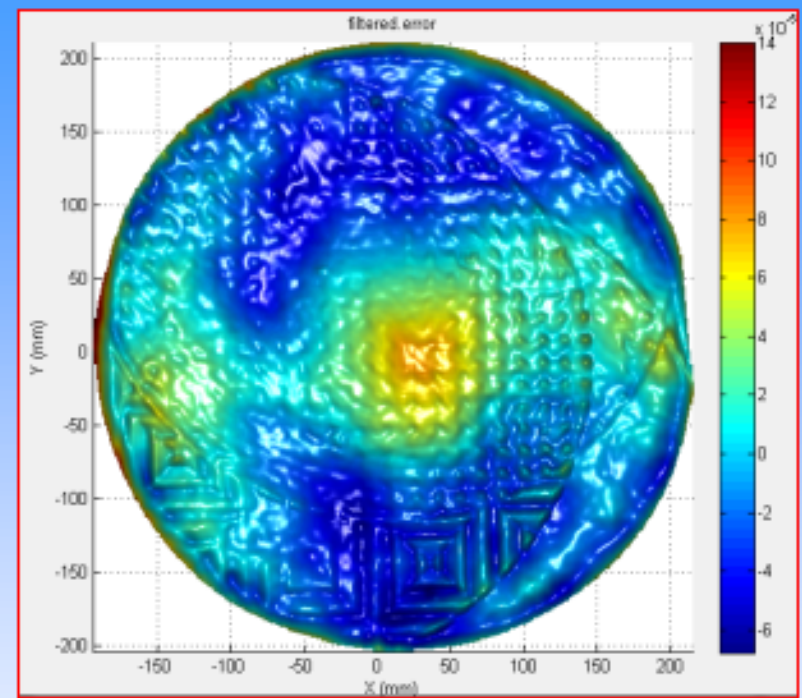
2. Raw sub-aperture measurements



3. Comparison



Full-aperture



Stitched

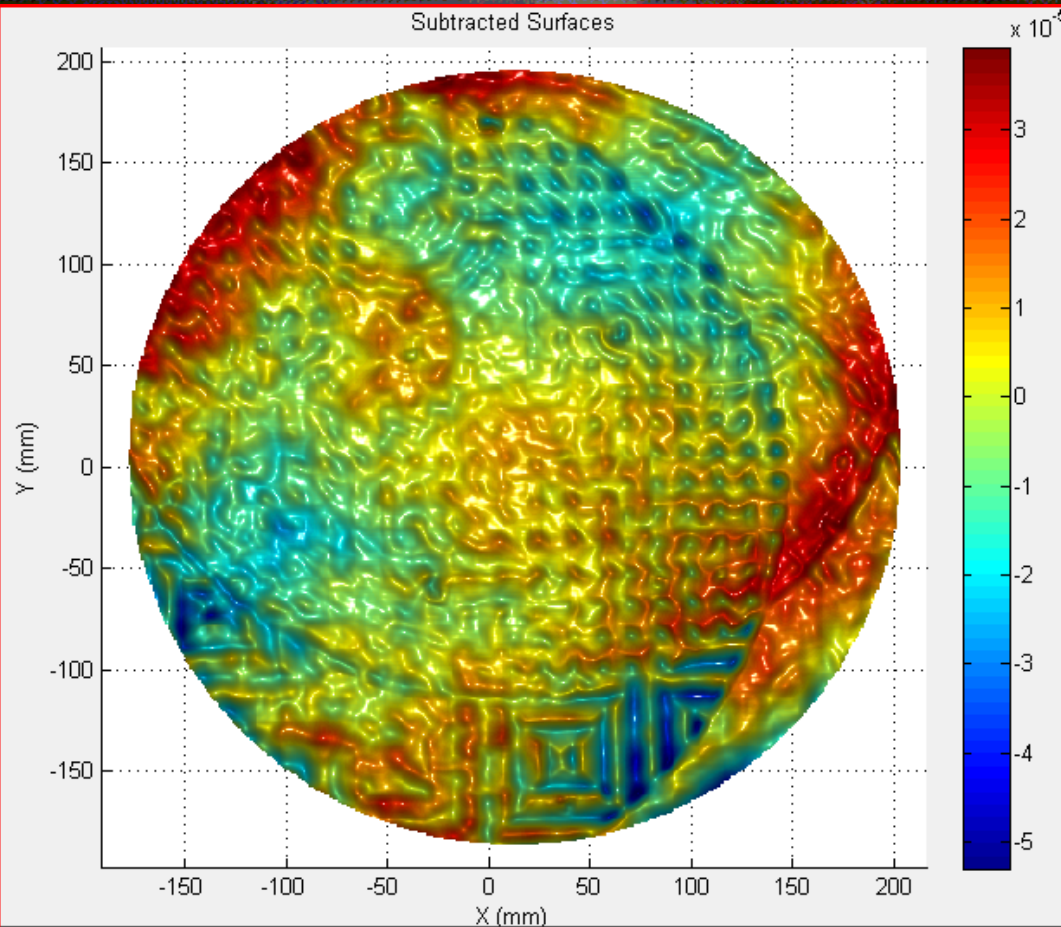
	RMS	PV
Full-aperture	32.0 nm	204 nm
Stitched	29.2 nm	208 nm

4. Difference full-aperture & stitched

PV=92 nm
RMS 11 nm

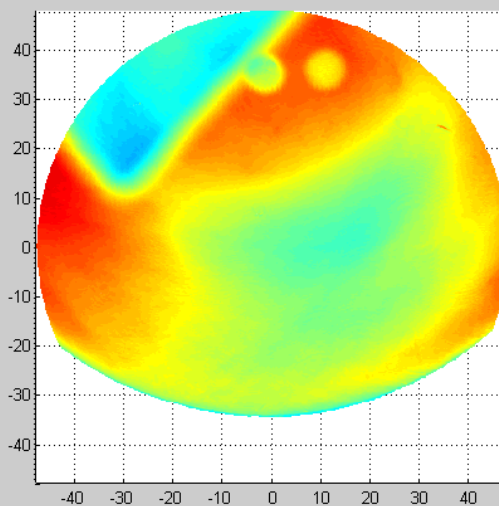
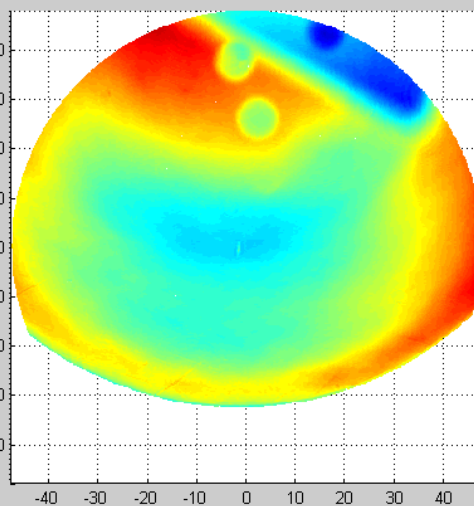
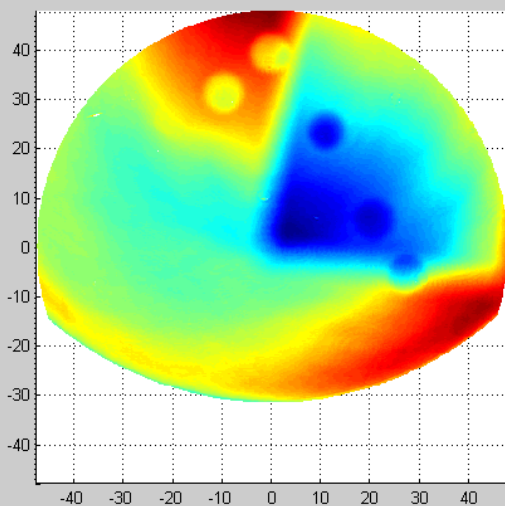
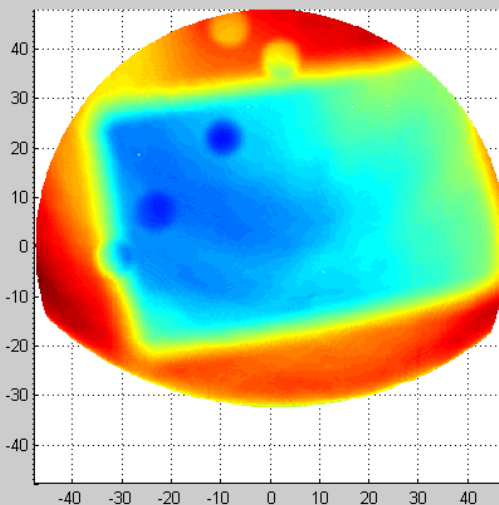
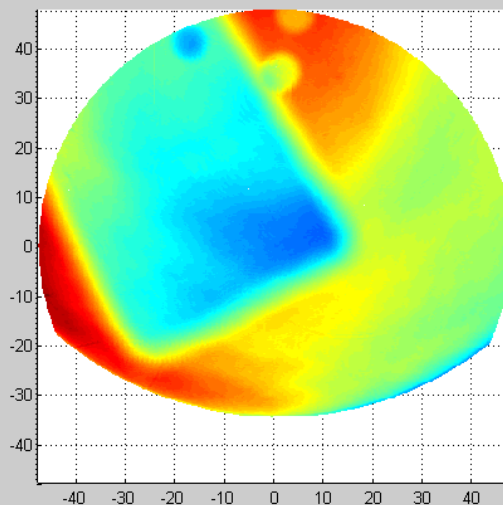
Much of the residual
error is systematic.
Calibration is
predicted to leave a
few nm residual.

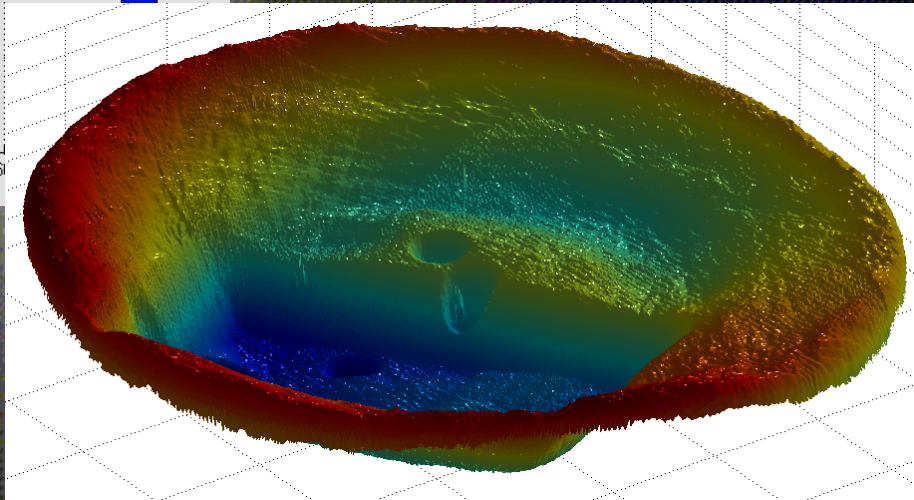
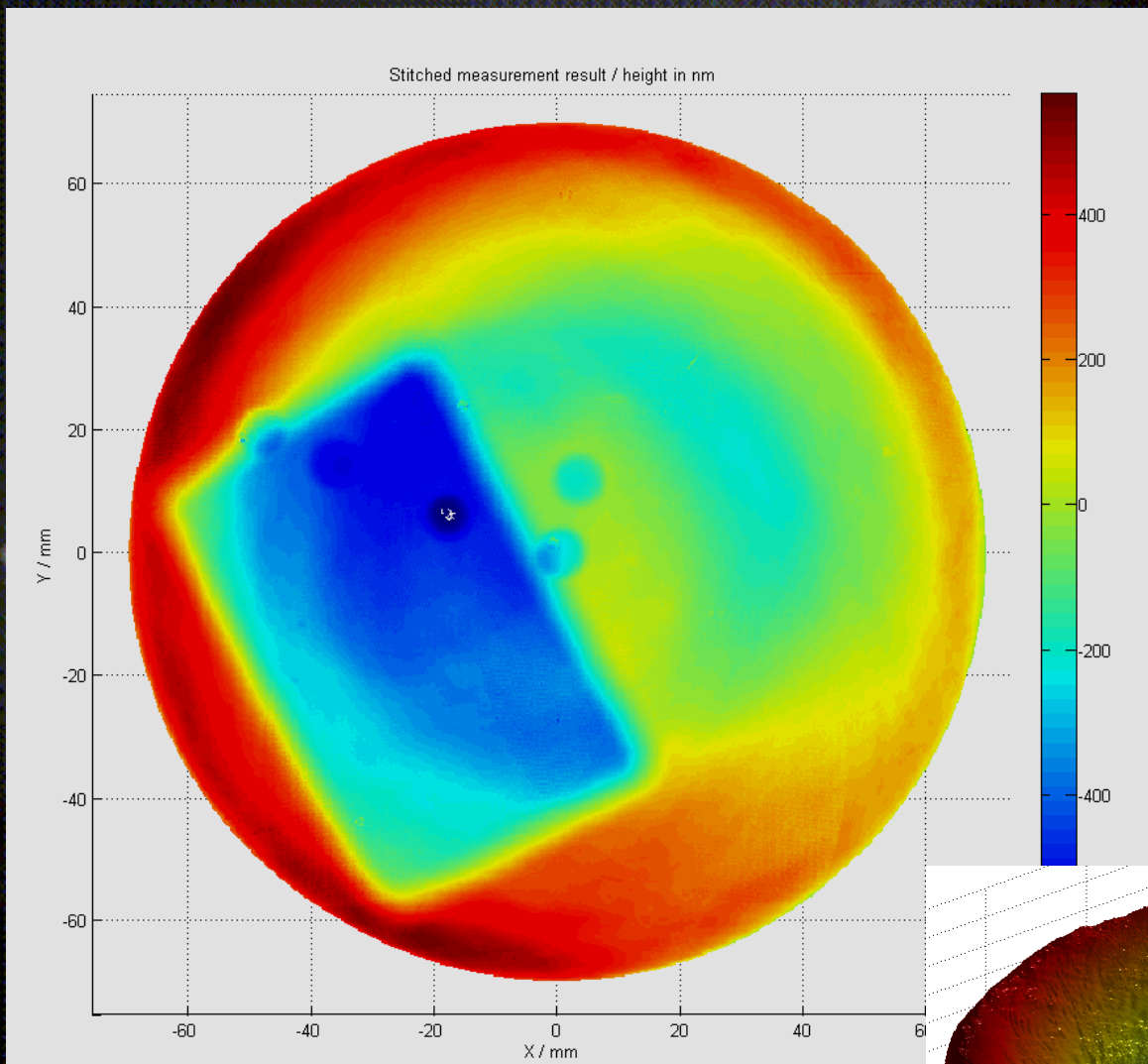
Expect residuals
~ X10 improvement
after calibration



Stitching a part with complex features (140mm diameter)

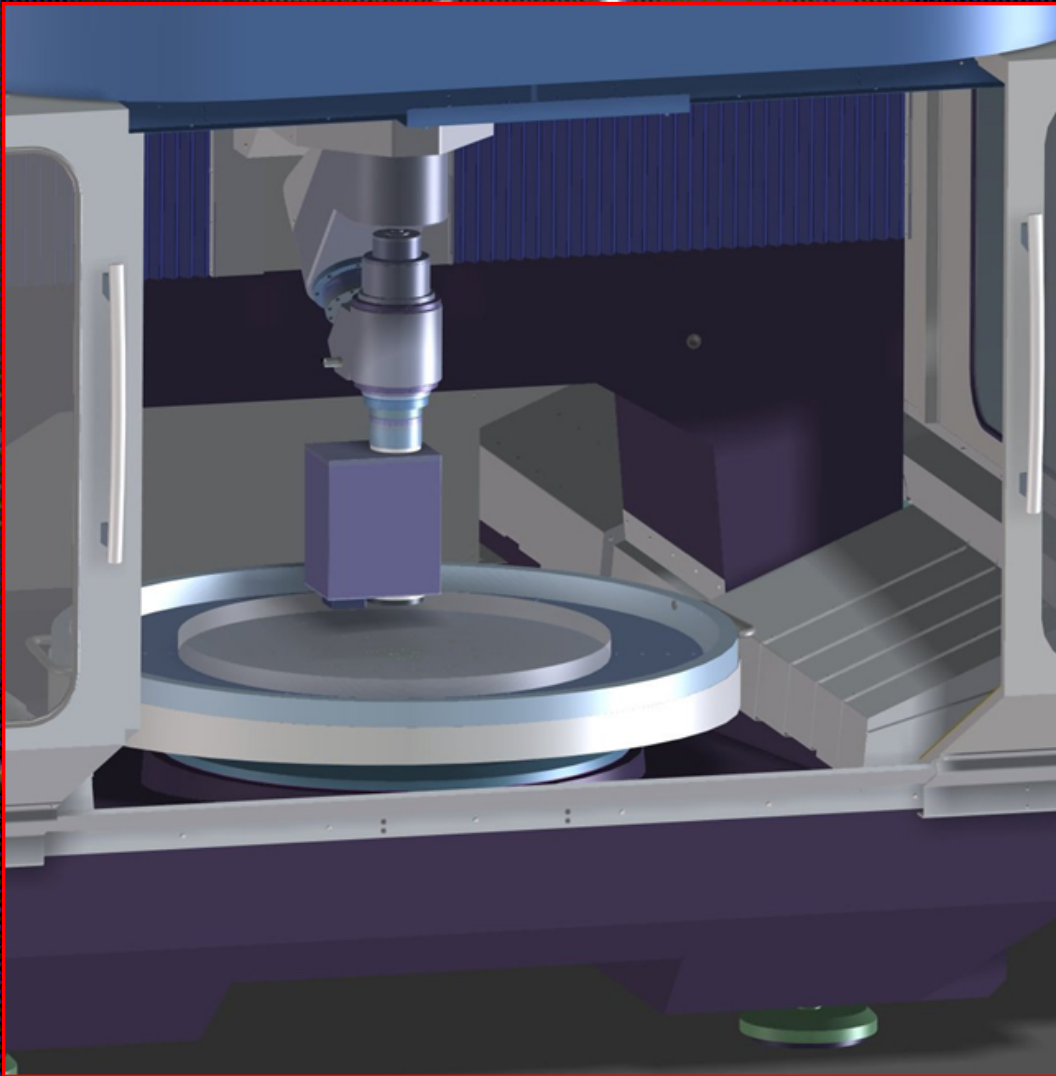
5 sub-aperture measurements
linear dimensions in mm





Module design: vibration and thermal

- Collaboration with 4D Technologies Corp.
 - 4D are developing a compact version of their simultaneous phase-shift interferometers
 - Short exposures freeze vibration
- Interferometer tests in machine environment confirm suitability for metrology
 - Polishing environment is flooded with polishing slurry at constant temperature when in use.



Module
concept in
polishing
machine

X,Y,Z,A,B
motions

Next stages

- Validate stitching on aspheres
- Evaluate prototype 4D compact interferometer
- Integrate optics and interferometer into on-machine module
- Formal consideration of uncertainty of measurement
- Delivery of first commercial system



Thank you!